Semiconductor Device Test Set - Page 1 of 1



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### **End Application:**

Milstar af terminal remoting syst m (maftrs)

### **Electrical Power Source Relationship:**

Operating

Internal Battery Accommodation:

Included

Inclosure Feature:

Single item w/housing

### Test Type For Which Designed:

Zener diodes testing in high altitude electromagnetic pulse (hemp) filters in milstar af terminal remoting system

### **Special Features:**

Open circuit voltage rise rate 200 v/s, 1000 v/s; output voltage 1000v; usable measuring range 10-1000 volts; test current for solid state protectors 1 ma at 10 pct; measurement accuracy .5 pct; 3 nema 5024 lithium batteries; storage temp m10 to 60 degrees c; operating

temp 0 to 50 degrees c

### **Functional Description:**

Uses a linear volt ramp generator, a low voltage capacitive discharge, current limit element, 1 mamp current detection & control circuit, & peak read metering system

# Supplementary Features:

Used in conjunction with rockwell built hemp filter test set; josyln calls this a surge protector test set

### Shelf Life:

N/a

### Unit Of Measure:

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### Demilitarization:

No

## Fiig:

T228-a